

Search Notes**Application/Control No.**

10/748,228

Examiner

Elias B. Hiruy

Applicant(s)/Patent under Reexamination

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Art Unit

2837

SEARCHED

Class	Subclass	Date	Examiner
318	375	1/28/2006	EH
318	379	1/28/2006	EH
318	380-381	1/28/2006	EH
318	362	1/28/2006	EH
318	366	1/28/2006	EH
318	268-269	1/28/2006	EH
318	376	2/13/2005	EH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Primary Examiner Rina Duda	2/1/2006	EH
(dynamic near2 brak\$3) same (brak\$3 near switch)) and (speed near2 (detect\$3 measur\$3 determin\$3))	1/28/2006	EH
((over adj3 voltage) near5 resistor) with (brak\$3 adj3 resistor) with control	1/30/2006	EH
Consulted with Primary Bentsu Ro regarding updated search finding.	2/13/2006	EH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same	as above	2/13/2006	EH